PART "B"

U.S. Department of Commerce, Patent and Trademark Office	Atty. Docket No.	Serial No.
	01N006-1C US	09/849,005
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Applicants: Chian-Min Ho et al.	
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RF	AC	5,600,787	2/4/97	Underwood et al.	395	183.06	
RF	AD	5,623,499	4/22/97	Ko et al.	371	22.1	
RF	AE	5,654,657	8/5/97	Pearce	327	163	
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RF	AK	Silburt, Allan, et al., "Accelerating Concurrent Hardware Design with Behavioral Modelling and System Simulation", 32nd Design Automation Conference, June 12-16, 1995, pp. 528-533.
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